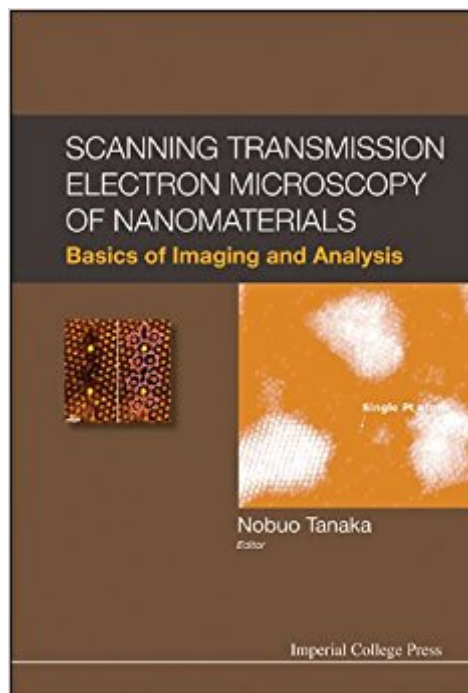




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# Scanning Transmission Electron Microscopy Of Nanomaterials : Basics Of Imaging And Analysis



## Synopsis

The basics, present status and future prospects of high-resolution scanning transmission electron microscopy (STEM) are described in the form of a textbook for advanced undergraduates and graduate students. This volume covers recent achievements in the field of STEM obtained with advanced technologies such as spherical aberration correction, monochromator, high-sensitivity electron energy loss spectroscopy and the software of image mapping. The future prospects chapter also deals with z-slice imaging and confocal STEM for 3D analysis of nanostructured materials.

**Contents:**    Introduction (N Tanaka)    Historical Survey of the Development of STEM Instruments (N Tanaka)    Basic Knowledge of STEM:    Basics of STEM (N Tanaka and K Saitoh)    Application of STEM to Nanomaterials and Biological Specimens (N Shibata, S D Findlay, Y Ikuhara and N Tanaka)    Theories of STEM Imaging:    Theory for HAADF-STEM and Its Image Simulation (K Watanabe)    Theory for Annular Bright Field STEM Imaging (S D Findlay, N Shibata and Y Ikuhara)    Electron Energy-Loss Spectroscopy in STEM and Its Imaging (K Kimoto)    Density Functional Theory for ELNES in STEM-EELS (T Mizoguchi)    Advanced Methods in STEM:    Aberration Correction in STEM (H Sawada)    Secondary Electron Microscopy in STEM (H Inada and Y Zhu)    Scanning Confocal Electron Microscopy (K Mitsuishi and M Takeguchi)    Electron Tomography in STEM (N Tanaka)    Electron Holography and Lorentz Electron Microscopy in STEM (N Tanaka)    Recent Topics and Future Prospects in STEM (N Tanaka)    Readership: Graduate students and researchers in the field of nanomaterials and nanostructures.

**Key Features:** Most advanced; befitting beginning graduate students Very convenient for advanced researchers who would like to use STEM and have a comprehensive understanding of the theory of image contrast and application details Spans from the basic theory to the applications of STEM

## Book Information

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